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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10449-032001	Application No. 09/748,506
	Disclosure Statement Applicant	Applicant Koji Hayashi et al.	
(Use sever	al sheets if necessary)	Filing Date December 26, 2000	Group Art Unit 2653

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	IU	Number	Date	Patent Office	Class	Subclass	Yes	No
Ke	AL	11-259982	24.09.1999	Japan				
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**Information Disclosure Statement** 

by Applicant (Use several sheets if necessary)

Attorney's Docket No. 10449-032001

Application No. 09/748,506

Applicant

Koji Hayashi et al.

Filing Date

Group Art Unit

(37 CFR §1.98(b))

December 26, 2000

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Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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Examiner	Desig.	Document	Publication	Country or			Trans	lation	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No	
ke	AL	10-063433	03/06/1998	Japan			X		
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	Other D	ocuments (include Author, Title, Date, and Place of Publication)
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Substitute Form PT (Modified)

Department of Commerce tent and Trademark Office Attorney's Docket No. 10449-032001

Application No. 09/748,506

Information MER Sure Statement by Applicant (Use several sheets if necessary)

Applicant Koji Hayashi et al.

Filing Date December 26, 2000 Group Art Unit
2653

(37 CFR §1.98(b))

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Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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Examiner	Desig.	Document	Publication	Country or				slation
Initial	ID ID	Number	Date	Patent Office	Class	Subclass	Yes	No.
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Other Documents (include Author, Title, Date, and Place of Publication)				
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Sheet 1	of	1
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Substitute Form PT 4449 (Modified)

6. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 10449-032001

Application No. 09/748,506

**Information Disclosure Statement** by Applicant (Use several sheets if necessary)

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Applicant

Group Art Unit

(37 CFR §1.98(b))

Filing Date December 26, 2000

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ec	AB	4,546,462	10/08/85	Koishi et al.	369	53.2/111	2 5 2002
a	AC	4,800,548	01/24/89	Koishi et al.	369	53.18	
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w.	AF	5,161,144	11/03/92	Takeuchi et al.	369	53.32	
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w	AO	2000-040302	02/08/00	Japan				

	Other Do	ocuments (include Author, Title, Date, and Place of Publication)
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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 10449-032001

Application No. 09/748,506

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant Koji Hayashi et al.

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December 26, 2000

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